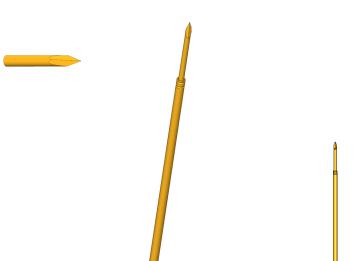
GKS-075 291 064 A 0600

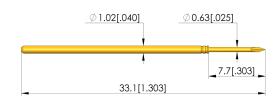
Item GKS-075-0428

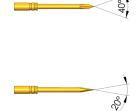




- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- Various spring forces available as well as versions with stainless steel springs suitable for high temperatures
- Used for setting the optimum stroke conditions in the test fixture, various installation heights can be achieved by combining test probes and receptacles







1:1

General data

Product group: ICT / FCT (in-circuit test and function test Sub-product group: Standard stroke test probe Series: GKS-075 Grid: 1.91 mm [75.1 mil] Contacting from:

Magnetic: Yes Installation type: Plug-in Quick-exchange system: Yes Adjustable installation height: No Non-rotating: No Compatible receptacle(s): KS-075 -40 °C [-40 °F] Min. temperature: Max. temperature: 80 °C [176 °F] RoHS-compliant: Yes

Tip style data

Tip style:	91 dagger, self-cleaning
Tip diameter:	0.64 mm [.025 in]
Tip style surface:	A gold
Tip style material:	2 steel

Electrical data

Current load capacity / rated current:	3 A
Typical resistance (Ri):	20 mOhm

Mechanical data

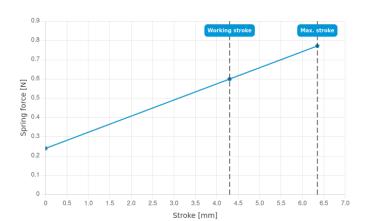
Total length:	33.1 mm [1.3 in]
Barrel diameter:	1.02 mm [.04 in]
Maximum stroke:	6.35 mm [.25 in]
Spring pre-load:	0.24 N [.863 ozf]
Collar height:	0
Spring force at working stroke:	0.6 N [2.15 ozf]
Recommended working stroke:	4.3 mm [.169 in]

Partner for Future Technology

Test Probe GKS-075 291 064 A 0600

Item GKS-075-0428





INGUN Prüfmittelbau GmbH

Max-Stromeyer-Straße 162 78467, Constance, Germany Phone +49 7531 8105-0 Customer hotline +49 7531 8105-888 Fax +49 7531 8105-65 info@ingun.com









Learn more about **ICT/FCT Test probes**

